| Notice of References Cited | Application/Control No. 09/966,890 | Applicant(s)/Patent Under Reexamination NEUFELD ET AL. | |
|---|---|---|---|
| | Examiner Tamara Teslovich | Art Unit 2137 | Page 1 of 1 |

## U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|---|---|---|
| | A | US-5,258,936 | 11-1993 | Gallup et al. | 708/254 |
| | B | US-5,363,448 | 11-1994 | Koopman et al. | 713/170 |
| | C | US-5,680,131 | 10-1997 | Utz, Hubert W. | 341/176 |
| | D | US-6,097,307 | 08-2000 | Utz, Hubert W. | 340/5.8 |
| | E | US-2002/0087857 | 07-2002 | Tsao et al. | 713/155 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

## FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|---|---|---|---|---|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

## NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | A. Menezes, P. van Oorschot, and S. Vanstone, "Handbook of Applied Cryptography", CRC Press, 1996 |
| | V | B. Schneier, "Applied Cryptography - Protocols, Algorithms and Source Code in C", Second Edition, John Wiley and Sons, New York, 1996 |
| | W | M. Jakobsson, E. Shriver, B. Hillyer and A. Juels, "A practical secure physical random bit generator", 1998, Proceedings of the 5th ACM conference on Computer and Communications Security, ACM Press, pg 103-111, <http://doi.acm.org/10.1145/288090.288114> |
| | X | Tim Matthews, "Suggestions for Random Number Generation in Software", 22 January 1996, RSA Laboratories Bulletin - News and Advice from RSA Laboratories, Number 1, pg 1-4 |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.